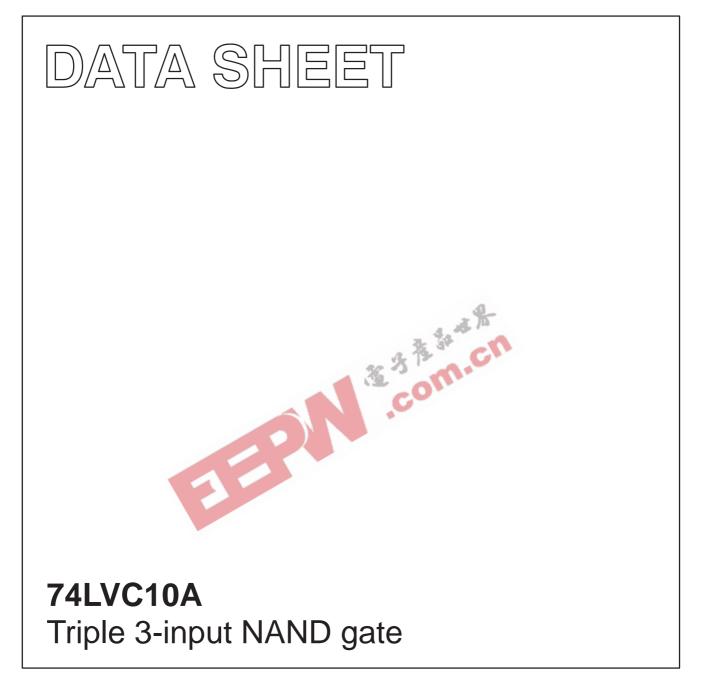
INTEGRATED CIRCUITS



Product specification

1998 Apr 28



74LVC10A

FEATURES

- Wide supply voltage range of 1.2 V to 3.6 V
- In accordance with JEDEC standard no. 8-1A.
- Inputs accept voltages up to 5.5 V
- CMOS low power consumption
- Direct interface with TTL levels
- Output capability: standard
- I_{CC} category: SSI

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25^{\circ}C$; $t_r = t_f \le 2.5$ ns

DESCRIPTION

The 74LVC10A is a high performance, low power, low voltage, Si gate CMOS device and superior to most advanced CMOS compatible TTL families.

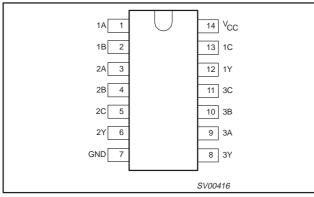
The 74LVC10A provides the 3-input NAND function.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT		
t _{PHL} /t _{PLH}	Propagation delay nA, nB, nC to nY	$\begin{array}{l} C_L = 50 \text{ pF}; \\ V_{CC} = 3.3 \text{ V} \end{array}$	3.9	ns		
Cl	Input capacitance		5.0	pF		
C _{PD}	Power dissipation capacitance per gate	$V_I = GND$ to V_{CC}^1	26	pF		
$P_D = C_{PD} \times V_{CC}^2 \times f_i = input frequency f_o = output frequent$						

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
14-Pin Plastic SO	-40°C to +85°C	74LVC10A D	74LVC10A D	SOT108-1
14-Pin Plastic SSOP Type II	-40°C to +85°C	74LVC10A DB	74LVC10A DB	SOT337-1
14-Pin Plastic TSSOP Type I	-40°C to +85°C	74LVC10A PW	74LVC10APW DH	SOT402-1

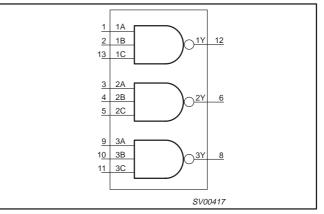
PIN CONFIGURATION



PIN DESCRIPTION

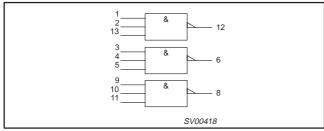
PIN NUMBER	SYMBOL	NAME AND FUNCTION	
1, 3, 9	1A – 3A	Data inputs	
2, 4, 10	1B – 3B	Data inputs	
7	GND	Ground (0 V)	
12, 6, 8	1Y – 3Y	Data outputs	
13, 5, 11	1C – 3C	Data inputs	
14	V _{CC}	Positive supply voltage	

LOGIC SYMBOL

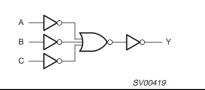


74LVC10A

LOGIC SYMBOL (IEEE/IEC)



LOGIC DIAGRAM (ONE GATE)



FUNCTION TABLE

	OUTPUTS		
nA	nB	nC	nY
L	L	L	Н
L	L	н	Н
L	н	L	н
L	Н	Н	Н
н	L	L	Н
Н	L	н	н
н	н	L L	н
Н	Н н	Н	L

NOTES:

H = HIGH voltage level L = LOW voltage level



RECOMMENDED OPERATING CONDITIONS

CYMDOL	PADAMETED		LIMITS			
SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT	
V _{CC}	DC supply voltage (for max. speed performance)		2.7	3.6	V	
V _{CC}	DC supply voltage (for low-voltage applications)		1.2	3.6	V	
VI	DC input voltage range		0	5.5	V	
Tamb	Operating free-air temperature range		-40	+85	°C	
t _r , t _f	Input rise and fall times	$V_{CC} = 1.2 \text{ to } 2.7 \text{V}$ $V_{CC} = 2.7 \text{ to } 3.6 \text{V}$	0 0	20 10	ns/V	

ABSOLUTE MAXIMUM RATINGS¹

In accordance with the Absolute Maximum Rating System (IEC 134). Voltages are referenced to GND (ground = 0V).

SYMBOL PARAMETER CONDITIONS RATING UNIT -0.5 to +6.5 DC supply voltage V V_{CC} I_{IK} DC input diode current $V_{|} < 0$ -50 mΑ V VI DC input voltage Note 2 -0.5 to +6.5 IOK DC output diode current $V_{O}>V_{CC} \mbox{ or } V_{O} < 0$ ± 50 mΑ DC output voltage; output HIGH or LOW Note 2 -0.5 to V_{CC} +0.5 V_{I/O} V -0.5 to 6.5 DC input voltage; output 3-State Note 2 I_{O} DC output source or sink current $V_{O} = 0$ to V_{CC} ± 50 mΑ DC V_{CC} or GND current ± 100 mΑ I_{GND}, I_{CC} -65 to +150 °C Storage temperature range T_{stg} Power dissipation per package P_{TOT} - plastic mini-pack (SO) above +70°C derate linearly with 8 mW/K 500 mW - plastic shrink mini-pack (SSOP and TSSOP) above +60°C derate linearly with 5.5 mW/K 500

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

Product specification

Triple 3-input NAND gate

74LVC10A

DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0V).

			LIMITS			UNIT	
SYMBOL	PARAMETER	TEST CONDITIONS	Temp = -				
			MIN	TYP ¹	MAX	1	
V		$V_{CC} = 1.2V$	V _{CC}			v	
VIH	HIGH level Input voltage	V _{CC} = 2.7 to 3.6V	2.0				
M		$V_{CC} = 1.2V$			GND	v	
V _{IL}	LOW level Input voltage	V _{CC} = 2.7 to 3.6V			0.8	1 ^v	
	V _{OH} HIGH level output voltage	$V_{CC} = 2.7V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -12mA$	$V_{CC} - 0.5$				
M		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -100 \mu A$	V _{CC} -0.2	V _{CC}			
∨он		$V_{CC} = 3.0V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -12mA$	$V_{CC} - 0.6$			V	
		$V_{CC} = 3.0V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -24mA$	$V_{CC} - 1.0$				
		$V_{CC} = 2.7V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 12mA$			0.40		
V _{OL}	LOW level output voltage	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$			0.20	0 V	
		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 24mA$			0.55	1	
lj	Input leakage current	V _{CC} = 3.6V; V _I = 5.5V or GND		±0.1	±5	μΑ	
I _{CC}	Quiescent supply current	$V_{CC} = 3.6V; V_1 = V_{CC} \text{ or GND}; I_0 = 0$		0.1	10	μΑ	
ΔI_{CC}	Additional quiescent supply current per input pin	V_{CC} = 2.7V to 3.6V; V_{I} = V_{CC} –0.6V; I_{O} = 0		5	500	μA	

NOTE:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C

AC CHARACTERISTICS

GND = 0 V; $t_r = t_f \le 2.5 \text{ ns}$; $C_L = 50 \text{ pF}$

					LIMITS			
SYMBOL	PARAMETER	WAVEFORM	Vc	c = 3.3V ±0	.3V	V _{CC} =	= 2.7V	UNIT
			MIN	TYP ¹	MAX	MIN	MAX	
t _{PHL} / t _{PLH}	Propagation delay nA, nB, nC to nY	Figures 1, 2	1.5	3.9	5.7	1.5	6.7	ns

NOTE:

1. These typical values are at $V_{CC} = 3.3V$ and $T_{amb} = 25^{\circ}C$.

AC WAVEFORMS

 V_{M} = 1.5 V at $V_{CC} \ge 2.7$ V

 $V_{M} = 0.5 \bullet V_{CC}$ at $V_{CC} < 2.7 V$

 V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load.

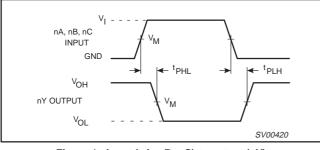


Figure 1. Input (nA, nB, nC) to output (nY) propagation delays.

TEST CIRCUIT

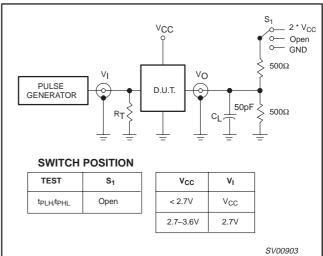


Figure 2. Load circuitry for switching times.

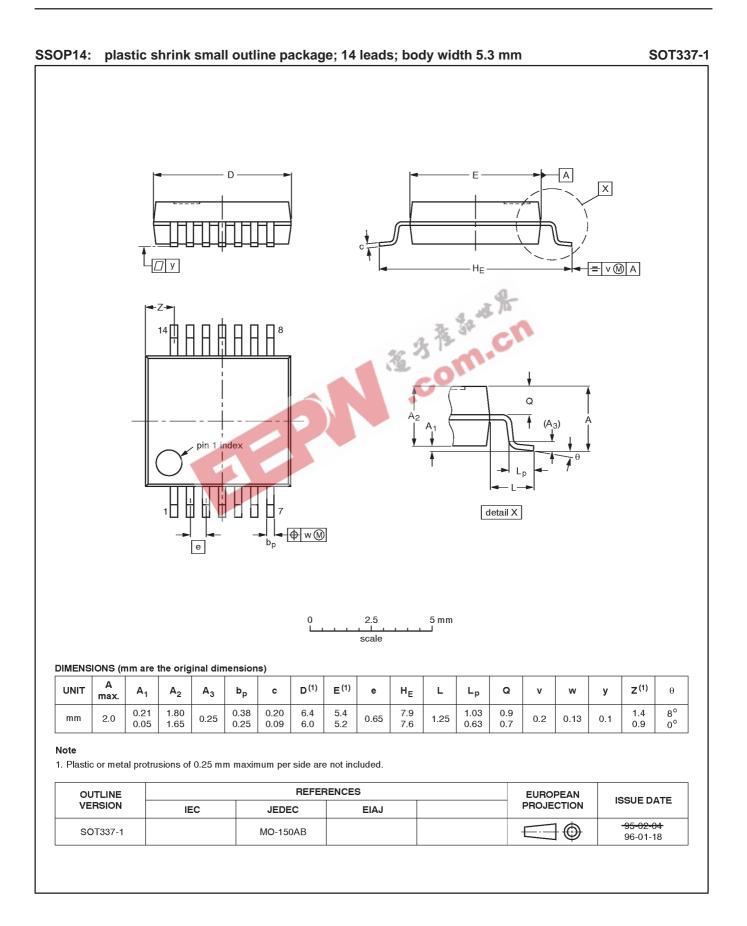
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plastic small outline package; 14 leads; body width 3.9 mm SOT108-1 SO14: А Г X = v 🕅 A H 为礼物 Ζ X Q (A₃) pin 1 index $\Phi \otimes \mathbb{M}$ detail X bp 2.5 5 mm scale DIMENSIONS (inch dimensions are derived from the original mm dimensions) Α Z ⁽¹⁾ D⁽¹⁾ E⁽¹⁾ UNIT A₁ A₂ A₃ bp С HE L Lp Q v θ е w У max 0.25 1.45 0.49 0.25 8.75 4.0 6.2 1.0 0.7 0.7 1.27 0.25 mm 1.75 0.25 1.05 0.25 0.1 8⁰ 0.10 0.36 0.19 8.55 5.8 0.4 0.3 1.25 3.8 0.6 0.244 0.028 $0^{\rm o}$ 0.010 0.057 0.019 0.0100 0.35 0.16 0.039 0.028 inches 0.069 0.01 0.050 0.041 0.01 0.01 0.004 0.004 0.049 0.014 0.0075 0.34 0.15 0.228 0.016 0.024 0.012 Note

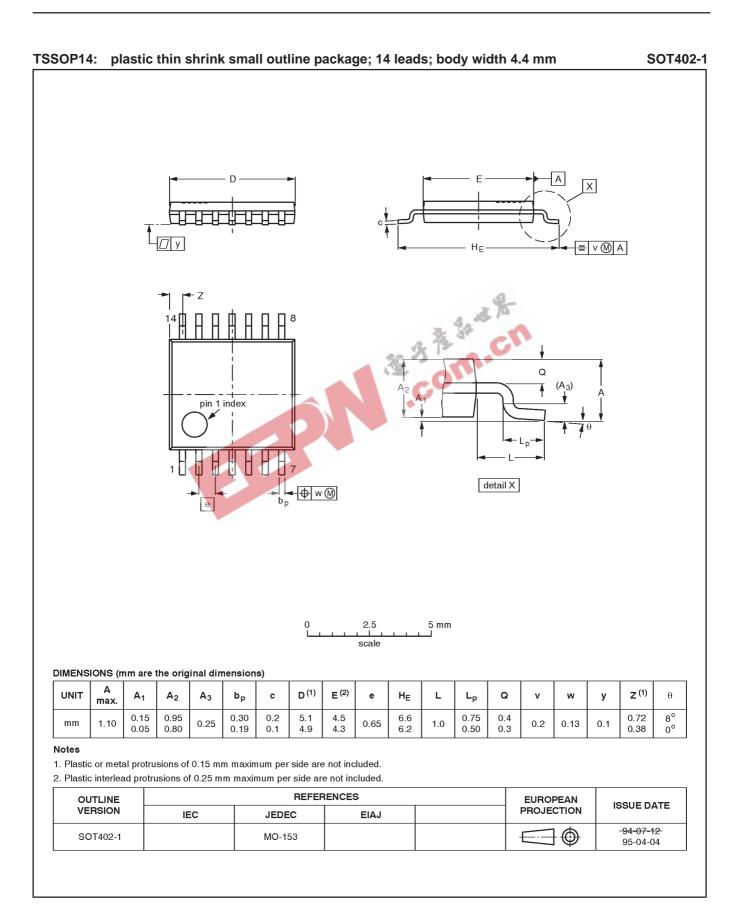
1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFERENCES					
VERSION	IEC	JEDEC	EIAJ		PROJECTION	1550E DATE	
SOT108-1	076E06S	MS-012AB				-95-01-23 97-05-22	

74LVC10A



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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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